



SMART  
Embedded  
Products

**SMART MODULAR  
BGAE340 eMMC Product Family  
eMMC v5.1 153-ball BGA**

**SPxMxGHxAHxx1**

***March 2025  
DSEM547-AK***

***[www.smartm.com](http://www.smartm.com)***

## REVISION HISTORY

Date	Revision	Section(s)	Description
August 2020	00	All	Preliminary Release.
September 2020	AA	All	Initial Release.
April 2021	AB	Figure 2	Update 153-Ball Pin Assignments.
April 2022	AC	All	Update the recommended capacitance for VDDi, VCC, and VCCQ.
November 2022	AD	All	Adding 8GB density.
January 2023	AE	All	Update Performance, Power Consumption
January 2023	AF	All	Update Endurance
June 2023	AG	Recommended Reflow Profiles	Update Recommended Values
July 2023	AH	Cover Page	Update Product Family Naming
January 2025	AI	All	Update VCCQ support for 8GB part numbers
February 2025	AJ	Features	Add the information of pSLC supporting
February 2025	AK	All	Add the information for new part number SPM8GH2AHW11



### ESD Caution – Handling

Static electricity may be discharged through this disk subsystem. In extreme cases, this may temporarily interrupt the operation or damage components. To prevent this, make sure you are working in an ESD-safe environment. For example, before handling the disk subsystem, touch a grounded device, such as a computer case, prior to handling.

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## Features

- **Capacity**
  - 4GB and 8GB (MLC)
  - 2GB and 4GB (pSLC)
- **Electrical/Physical Interface**
  - Compliant with eMMC Specification Version 5.1
  - 153 Ball Standard BGA Packages
- **Bus Mode<sup>1</sup>**
  - High-speed eMMC protocol
    - SDR52, DDR52, HS200, and HS400
  - Clock frequency: 0-200MHz.
  - Ten-wire bus (clock, 1-bit command, 8-bit data bus) and a hardware reset
- **Bus Width**
  - 1-bit, 4-bit, 8-bit
- **Performance (HS400)**
  - Read:
    - Up to 250MB/s
  - Write:
    - Up to 65MB/s
- **Operating Temperature<sup>2</sup>**
  - Industrial: -40°C to +85°C
  - Wide: -40°C to +105°C
- **Storage Temperature<sup>2</sup>**
  - Industrial: -40°C to +85°C
  - Wide: -40°C to +105°C
- **Input Power<sup>3</sup>:**
  - V<sub>CC</sub>: 2.7 – 3.6V
  - V<sub>CCQ</sub> (Dual voltage): 1.7 – 1.95V or 2.7 – 3.6V
- **Power Consumption (HS400, I<sub>CC</sub>/I<sub>CCQ</sub>)**
  - Read: 111/149mA
  - Write: 59/84mA
  - Standby: 110/470 µA
- **Certification & Compliance**
  - RoHS
  - REACH
  - Green Package
- **NAND Technology**
  - MLC and pSLC
- **Reliability**
  - Configurable error correction code (ECC)
  - Defect block management
  - Wear leveling
  - Garbage collection
  - Uncorrectable bit error rate (UBER): 1 sector per 10<sup>15</sup> bits read
- **Security**
  - Sanitize, Discard, trim, Erase
  - Lock/Unlock, Secure Removal Type
  - Write protect, Secure Write Protection
- **Additional Features**
  - Field firmware update (FFU)
  - Production state awareness (PSA)
  - Device health report
  - Replay Protected Memory Block (RPMB)
  - Boot and Alternative Boot Mode
  - High Priority Interrupt (HPI)
  - Command Queuing
  - Configurable Drive Strength
  - Hardware/Software Reset
  - Cache flushing report
  - Cache barrier
  - PON, Sleep/Awake

### NOTES:

<sup>1</sup> HS200 and HS400 modes are supported only when V<sub>CCQ</sub> is in 1.7 – 1.95V.

<sup>2</sup> Ambient temperature.

<sup>3</sup> 8GB(native)/4GB(pSLC pre-config) part numbers only support VCCQ: 1.7 – 1.95V.

## General Description

### Overview

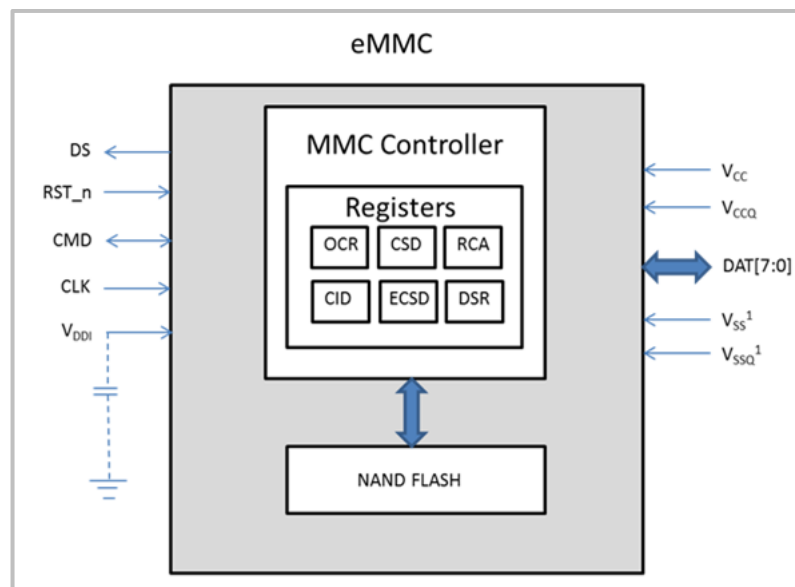
SMART Modular's eMMC Product Family is an embedded Flash storage solution in a small BGA package designed specifically for the most demanding applications. SMART's eMMC products address the need for enhanced reliability by incorporating on-board error detection and correction, wear leveling algorithms, and other data management techniques to provide reliable operation and maximum NAND media life expectancy over the product life cycle.

Additionally, the eMMC controller and firmware hide the increased complexities of NAND media from the host processor and allow for faster product development and time to market.

Target applications for SMART's eMMC solution include but are not limited to IoT, Set Top Box, Industrial and Networking appliances wanting a rugged yet cost effective high density mass storage solution.

## Functional Block Diagram

### eMMC Block Diagram



## Performance

### Performance Characteristics (MLC Partition Burst Performance)

Capacity	HS400 Performance			
	Seq. Read (MB/s)	Seq. Write (MB/s)	Random Read 4KB (IOPS)	Random Write 4KB (IOPS)
4 GB (native) No pre-configuration	170	15	5345	980
8 GB (native) No pre-configuration	250	65	9785	1870

Capacity	H200 Performance			
	Seq. Read (MB/s)	Seq. Write (MB/s)	Random Read 4KB (IOPS)	Random Write 4KB (IOPS)
4 GB (native) No pre-configuration	155	15	4890	980
8 GB (native) No pre-configuration	180	65	9305	1820

Capacity	DDR52 Performance			
	Seq. Read (MB/s)	Seq. Write (MB/s)	Random Read 4KB (IOPS)	Random Write 4KB (IOPS)
4 GB (native) No pre-configuration	95	15	4610	980
8 GB (native) No pre-configuration	95	65	7900	2140

Performance measured based on the following conditions:

<sup>1</sup> Testmetrix VTESA-4100E; bus in x8 I/O mode.

## Performance Characteristics (pSLC Partition Burst Performance)

Capacity	HS400 Performance			
	Seq. Read (MB/s)	Seq. Write (MB/s)	Random Read 4KB (IOPS)	Random Write 4KB (IOPS)
2 GB (pSLC) Pre-configuration	170	25	5345	980
4 GB (pSLC) Pre-configuration	250	65	10000	2000

Capacity	H200 Performance			
	Seq. Read (MB/s)	Seq. Write (MB/s)	Random Read 4KB (IOPS)	Random Write 4KB (IOPS)
2 GB (pSLC) Pre-configuration	155	25	4890	980
4 GB (pSLC) Pre-configuration	180	65	9800	2000

Capacity	DDR52 Performance			
	Seq. Read (MB/s)	Seq. Write (MB/s)	Random Read 4KB (IOPS)	Random Write 4KB (IOPS)
2 GB (pSLC) Pre-configuration	95	25	4610	980
4 GB (pSLC) Pre-configuration	95	65	8000	2200

Performance measured based on the following conditions:

<sup>1</sup> Testmetrix VTESA-4100E; bus in x8 I/O mode.

## Endurance

### Drive Lifetime<sup>1</sup>

Capacity	Value (Max)	
4GB (native)	100% Sequential Workload	10 TBW
8GB (native)		20 TBW
2GB (pSLC)		50 TBW
4GB (pSLC)		100 TBW

<sup>1</sup> Endurance is related directly to the User Specific Workload. Measured with 100% Sequential Workload.

## Reliability

### Uncorrectable Bit Error Rate (UBER)

#### Industrial Temperature

Failure Rate	All capacities
FIT @ T <sub>c</sub> = 55°C	62.17 (153ball)

#### Wide Temperature

Failure Rate	All capacities
FIT @ T <sub>c</sub> = 72°C	39.88 (153ball)

### Uncorrectable Bit Error Rate (UBER)

Parameter	Value
Data Reliability	< 1E <sup>-15</sup> uncorrectable bit error rate

## Data Retention

### Industrial Temperature

Parameter	Value
Data Retention (@ 40°C)	10 years when 90% life remaining
	1 year when 10% life remaining

### Wide Temperature

Parameter	Value
Data Retention (@ 55°C)	10 years when 90% life remaining
	1 year when 10% life remaining

## Operating and Storage Temperature<sup>1</sup>

Parameter	Value	
Operating Temperature	Industrial	-40°C to +85°C
	Wide	-40°C to +105°C
Storage Temperature	Industrial	-40°C to +85°C
	Wide	-40°C to +105°C

<sup>1</sup> Operating temperature herein is Ambient Temperature.

## Power (Current) Consumption

Condition <sup>1</sup>		I <sub>cc</sub> /I <sub>ccq</sub> (Typical)				Units
		4GB (native)	8GB (native)	2GB (pSLC)	4GB (pSLC)	
Write	DDR52	32/43	47/80	30/43	40/78	mA
	HS200	33/43	59/84	32/43	59/78	mA
	HS400	33/43	59/84	33/44	59/83	mA
Read	DDR52	49/145	42/149	46/145	45/145	mA
	HS200	89/145	80/149	88/45	86/145	mA
	HS400	92/145	111/149	95/145	109/145	mA
Idle		110/470	110/470	110/470	110/470	μA

<sup>1</sup> Bus in x8 I/O mode; 25°C; V<sub>CCQ</sub> = 1.95 V in HS200 and HS400. Measurements done as maximum RMS current consumption over 100 milliseconds.

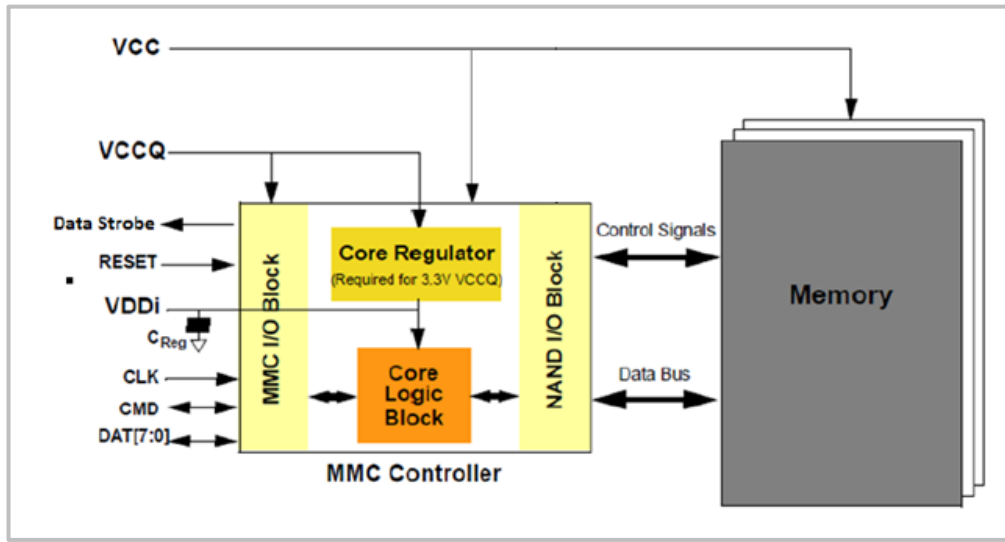


## Electrical Specification

The device current consumption for various device configurations is defined in the power class fields of the ECSD register.

$V_{CC}$  is the supply voltage for controller and Flash memory power;  $V_{CCQ}$  is the supply voltage for controller and eMMC I/O voltage.

## Power Connections



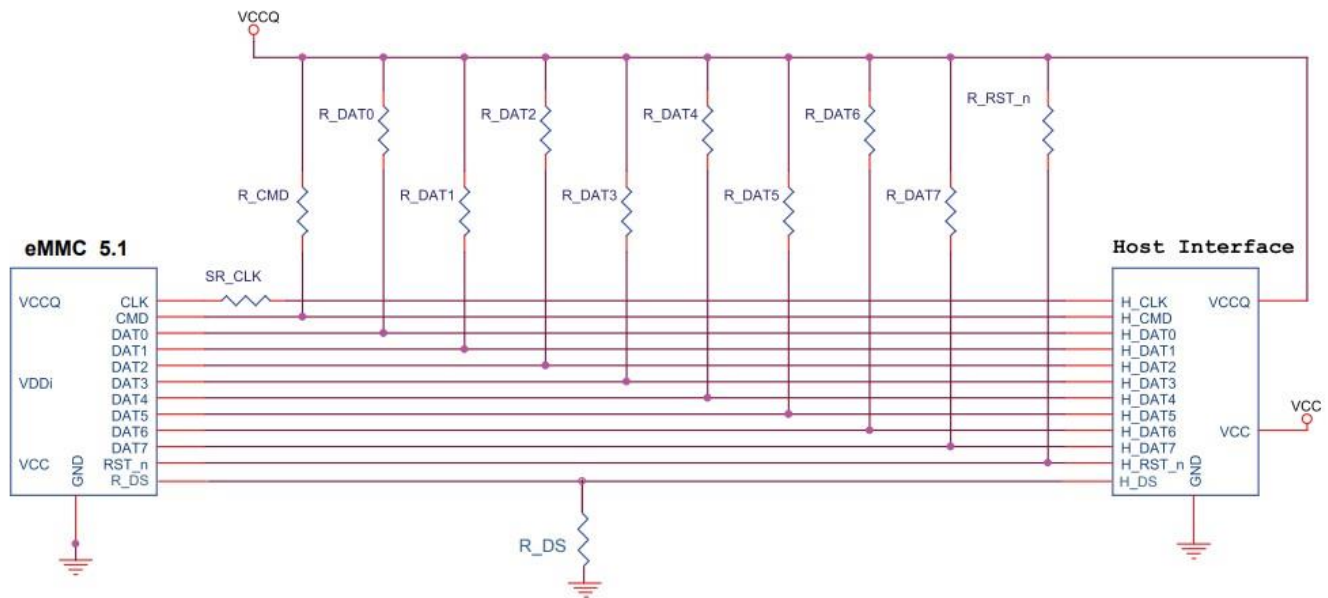
## Power Requirements

Symbol	Parameter	Value (Minimum)	Value (Typical)	Value (Maximum)	Unit
$V_{CC}$	Voltage supply to Flash memory	2.7	3.3	3.6	V
$V_{CCQ}^1$	Voltage supply to host interface	2.7 (high range) 1.70 (low range)	3.3 (high range) 1.80 (low range)	3.6 (high range) 1.95 (low range)	V
$V_{DDi}$	Internal voltage regulator connection to external capacitor	-	-	-	-

### NOTES:

<sup>1</sup> 8GB(native)/4GB(pSLC pre-config) part numbers only support  $V_{CCQ}$ : 1.7 – 1.95V.

## Recommended eMMC Connection



## Resistor Specifications

Parameter <sup>1</sup>	Symbol	Min.	Max.	Recommended	Unit	Remark
Pull-up resistance for CMD	R_CMD	4.7	50	10	kΩ	To prevent bus from floating
Pull-up resistance for DAT0-7	R_DAT0~7	10	50	50	kΩ	To prevent bus from floating
Pull-up resistance for RST_n	R_RST_n	4.7	50	50	kΩ	It's not necessary to put pull-up resistance on RST_n (H/W reset) line if host does not use H/W reset.
Pull-down resistance for R_DS	R_DS	10	50	50	kΩ	
Impedance on CLK/CMD/DAT0~7	-	45	55	50	Ω	Impedance match
Serial resistance on CLK	SR_CLK	-	-	22	Ω	To put serial resistance except 0 ohm, check timing are all in Spec.

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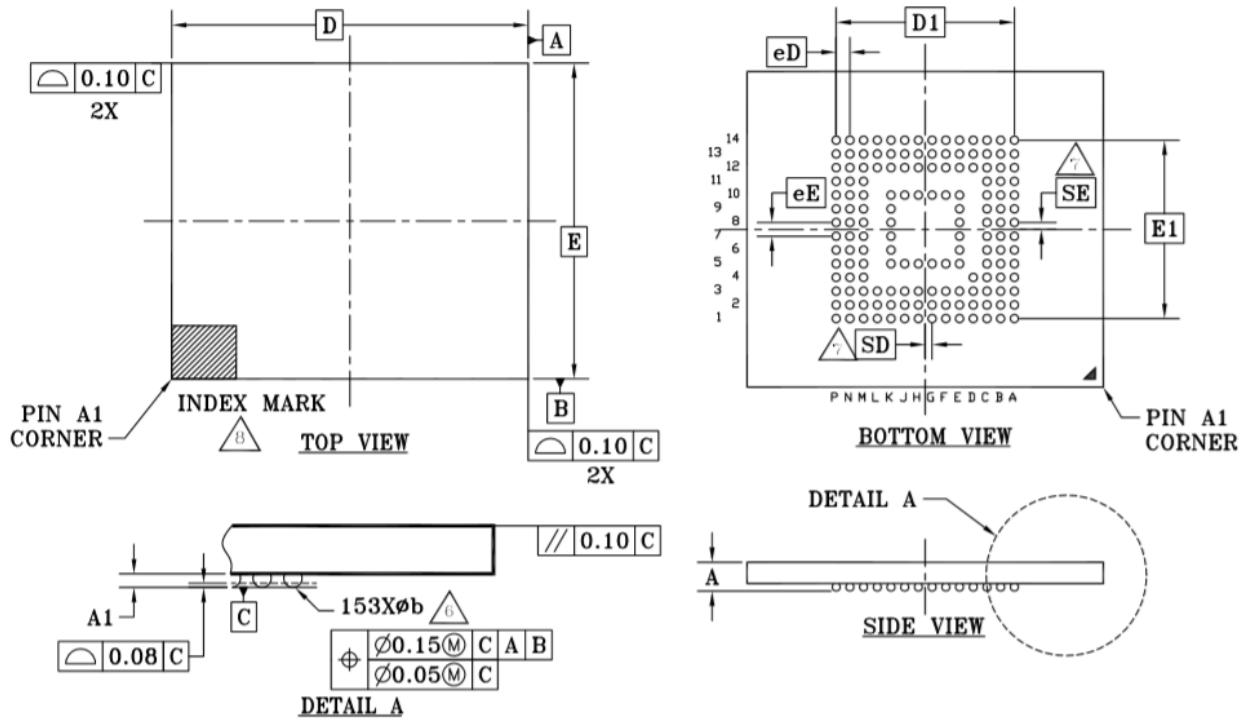
## Decoupling Capacitor Recommendations

- X7R or X5R capacitors are recommended with a rated voltage > 6.3V.
- 0603 or a smaller size is recommended.
- Pick capacitors with low ESL and ESR.
- It is important to place decoupling caps as close to the target supply balls while maintaining > 20 mil trace width for supply connections to capacitor SMT pads.
- Recommended Value and Quantity:
  - VCCQ: More than 0.1  $\mu\text{F}$  x 1, 2.2  $\mu\text{F}$  x 1 (for BGA153, this cap should be as close as possible to C6 ball), and 1 x 1  $\mu\text{F}$
  - VCC: More than 0.1  $\mu\text{F}$  x 1 and 2.2  $\mu\text{F}$  x 1
  - VDDi: More than 0.1  $\mu\text{F}$  x 1 and 2.2  $\mu\text{F}$  x 1
  - A minimum of 1 $\mu\text{F}$  is required for VCCQ, VCC, and VDDi.

Customer requested to place all of the caps shown above. For VCCQ caps, they should be located as close as possible to the VCCQ/VSSQ balls near the DAT0-7 signals.

## Mechanical Specification

### 153-Ball BGA Dimensions - 11.5 mm x 13.0 mm x 0.8 mm



PACKAGE	TBD 153			NOTE
JEDEC	MO-276			
D X E	13.00mm X 11.50mm PACKAGE			
SYMBOL	MIN.	NOM.	MAX.	
A	0.70	---	0.80	PROFILE
A1	0.17	---	---	BALL HEIGHT
D	13.00 BSC			BODY SIZE
E	11.50 BSC			BODY SIZE
D1	6.50 BSC			MATRIX FOOTPRINT
E1	6.50 BSC			MATRIX FOOTPRINT
MD	14			MATRIX SIZE D DIRECTION
ME	14			MATRIX SIZE E DIRECTION
n	153			BALL COUNT
øb	0.25	0.30	0.35	BALL DIAMETER
eE	0.50 BSC			BALL PITCH
eD	0.50 BSC			BALL PITCH
SD/SE	0.25 BSC			SOLDER BALL PLACEMENT
	D5-D11,E11-K11,L4-L11,E4-K4 F6-F9,G6-G9,H6-H9,J6-J9			DEPOPULATED SOLDER BALLS

#### NOTES:

- DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5-2009. THIS OUTLINE CONFORMS TO JEP 95, SECTION 4.6.
- ALL DIMENSIONS ARE IN MILLIMETERS.
- BALL POSITION DESIGNATION PER JEP 95, SECTION 3, SPP-020.
- [e] REPRESENTS THE SOLDER BALL GRID PITCH.
- SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION. SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION. n IS THE NUMBER OF POPULATED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.
- [6] DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.
- [7] [SD] AND [SE] ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW. WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW [D] OR [SE] = 0.000. WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW [SD] OR [SE] = e/2
- [8] A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.
- TEST PADS MAY BE PRESENT BUT ARE NOT SHOWN. THEY ARE FOR INTERNAL USE ONLY AND ARE NOT SOLDER BALLS.

## Mechanical Dimensions

Parameter	Value
Length	13.00 mm [0.51in]
Width	11.50 mm [0.45in]
Height	0.80 mm [0.0315in]

## 153-Ball eMMC Ball-out Diagram (Top View, Ball Down)

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	
A	NC	NC	DAT0	DAT1	DAT2	VSS	RFU	NC	NC	NC	NC	NC	NC	NC	A
B	NC	DAT3	DAT4	DAT5	DAT6	DAT7	NC	NC	NC	NC	NC	NC	NC	NC	B
C	NC	VDDI	NC	VSSQ	NC	VCCQ	NC	NC	NC	NC	NC	NC	NC	NC	C
D	NC	NC	NC	NC								NC	NC	NC	D
E	NC	NC	NC		RFU	VCC	VSS	RFU	RFU	RFU		NC	NC	NC	E
F	NC	NC	NC		VCC						RFU	NC	NC	NC	F
G	NC	NC	RFU		VSS						RFU	NC	NC	NC	G
H	NC	NC	NC		DS						VSS	NC	NC	NC	H
J	NC	NC	NC		VSS						VCC	NC	NC	NC	J
K	NC	NC	NC		RST_n	RFU	RFU	VSS	VCC	RFU		NC	NC	NC	K
L	NC	NC	NC									NC	NC	NC	L
M	NC	NC	NC	VCCQ	CMD	CLK	NC	NC	NC	NC	NC	NC	NC	NC	M
N	NC	VSSQ	NC	VCCQ	VSSQ	NC	NC	NC	NC	NC	NC	NC	NC	NC	N
P	NC	NC	VCCQ	VSSQ	VCCQ	VSSQ	RFU	NC	NC	RFU	NC	NC	NC	NC	P
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	

## Pinout Descriptions

### Signal Descriptions

Signal	Type	Description
CLK	Input	Clock. Each cycle of the clock directs a transfer on the command line and on the data line(s). The frequency can vary between the minimum and the maximum clock frequency.
DS	Output	eMMC interface data strobe (HS400 mode)
CMD	I/O	Command. This signal is a bidirectional command channel used for command and response transfers. The CMD signal has two bus modes: open-drain mode and push-pull mode. Commands are sent from the MMC host to the device, and responses are sent from the device to the host.
DAT0 – DAT7	I/O	Data I/O. These are bidirectional data signals. The DAT signals operate in push-pull mode. By default, after power-up or assertion of the RST_n signal, only DAT0 is used for data transfer. The MMC controller can configure a wider data bus for data transfer using either DAT[3:0] (4-bit mode) or DAT[7:0] (8-bit mode). eMMC includes internal pull-up resistors for data lines DAT[7:1]. Immediately after entering the 4-bit mode, the device disconnects the internal pull-up resistors on the DAT[3:1] lines. Correspondingly, immediately after entering the 8-bit mode, the device disconnects the internal pull-ups on the DAT[7:1] lines.
RST_n	Input	Reset. The RST_n signal is used for host resetting device, moving the device to pre-idle state. By default, the RST_n signal is temporary disabled in device. The host must set bits[1:0] in the extended CSD register [162] to 0x1 to enable this functionality before the host can use it.
VCC	Supply	NAND interface I/O and NAND Flash power supply.
VCCQ	Supply	eMMC controller core and eMMC interface I/O power supply.
VSS	Supply	NAND interface I/O and NAND Flash ground connection.
VSSQ	Supply	eMMC controller core and eMMC interface ground connection.
VDDi	-	Internal voltage node 0.1 $\mu$ F x 1 and 2.2 $\mu$ F x 1 capacitors are recommended for VDDi for core power stabilization.* Do not tie to supply voltage or ground.
NC	-	No connect
RFU	-	Reserved for future use. Leave it floating.

\* A minimum of 1 $\mu$ F is required.

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## Recommended Reflow Profiles

Reflow Parameters	Suggested Range
Peak Temperature	235 - 245°C
Time Above liquidus	45 to 70 seconds
Cooling Rate	< 4°C/sec

**Note:** Each solder paste manufacturer will have their own reflow profile specification. It's recommended customers follow the solder paste manufacturer's reflow profile specification and optimize the reflow profile based on product complexity for the assembly process.

## Registers

### Supported Device Registers

Name	Width	Description
CID	128 (Bits)	Card Identification
OCR	32 (Bits)	Operation Condition Register
CSD	128 (Bits)	Card Specific Data
ECSD	512 (Bytes)	Extended Card Specific Data

### CID Register Field Parameters

Name	Field	Width (Bits)	CID Bits	CID Value
Manufacturer ID	MID	8	[127:120]	0x01
Reserved	-	6	[119:114]	--
Device / BGA	CBX	2	[113:112]	0x01
OEM/application ID	OID	8	[111:104]	0x00
Product name	PNM	48	[103:56]	4GB:0x533430303034 8GB:0x533430303038
Product revision	PRV	8	[55:48]	4GB:0x01 8GB:0x10
Product serial number	PSN	32	[47:16]	-- <sup>(1)</sup>
Manufacturing date	MDT	8	[15:8]	-- <sup>(2)</sup>
CRC7 checksum	CRC	7	[7:1]	-- <sup>(3)</sup>
reserved	-	1	0	--

<sup>1</sup> The product name uses ASCII code and 'Δ' is a space (0x20).

<sup>2</sup> Unique for each device. 32-bit unsigned binary integer.

<sup>3</sup> 2 hex digits for device manufacturing month and year.

<sup>4</sup> CRC for CID register. Different for each device.

### OCR Register Field Definitions

V <sub>DD</sub> voltage window	Width (Bits)	OCR bits	OCR Value
Ready/Busy	1	[31]	card power up status bit (busy) <sup>(1)</sup>
Access Mode	2	[30:29]	10b
Reserved	5	[28:24]	--
VCCQ: 2.7-3.6V	9	[23:15]	1 1111 1111b
VCCQ: 2.0-2.6V	7	[14:8]	000 0000b
VCCQ: 1.70-1.95V	1	[7]	1b
Reserved	7	[6:0]	--

<sup>1</sup> This bit is set to LOW if the device has not finished the power up routine.

<sup>2</sup> The voltage for internal flash memory (VCC) should be 2.7-3.6V regardless of OCR Register value.

<sup>3</sup> 8GB(native)/4GB(pSLC pre-config) part numbers do not support VCCQ in 2.7-3.6V



## CSD Register Field Parameters

Name	Field	Width (Bits)	Cell Type <sup>1</sup>	CSD Bits	Value	
CSD structure	CSD_STRUCTURE	2	R	[127:126]	3h	
System specification version	SPEC_VERS	4	R	[125:122]	4h	
Reserved	-	2	R	[121:120]	-	
Data read access-time 1	TAAC	8	R	[119:112]	27h	
Data read access-time 2 in CLK cycles (NSAC*100)	NSAC	8	R	[111:104]	1h	
Max. bus clock frequency	TRAN_SPEED	8	R	[103:96]	32h	
Device command classes	CCC	12	R	[95:84]	F5h	
Max. read data block length	READ_BL_LEN	4	R	[83:80]	9h	
Partial blocks for read allowed	READ_BL_PARTIAL	1	R	[79:79]	0h	
Write block misalignment	WRITE_BLK_MISALIGN	1	R	[78:78]	0h	
Read block misalignment	READ_BLK_MISALIGN	1	R	[77:77]	0h	
DSR implemented	DSR_IMP	1	R	[76:76]	0h	
Reserved	-	2	R	[75:74]	0h	
Device size	C_SIZE	12	R	[73:62]	FFFh	
Max. read current @ VDD min	VDD_R_CURR_MIN	3	R	[61:59]	7h	
Max. read current @ VDD max	VDD_R_CURR_MAX	3	R	[58:56]	7h	
Max. write current @ VDD min	VDD_W_CURR_MIN	3	R	[55:53]	7h	
Max. write current @ VDD max	VDD_W_CURR_MAX	3	R	[52:50]	7h	
Device size multiplier	C_SIZE_MULT	3	R	[49:47]	7h	
Erase group size	ERASE_GRP_SIZE	5	R	[46:42]	1Fh	
Erase group size multiplier	ERASE_GRP_MULT	5	R	[41:37]	1Fh	
Write protect group size	WP_GRP_SIZE	5	R	[36:32]	0Fh	
Write protect group enable	WP_GRP_ENABLE	1	R	[31:31]	1h	
Manufacturer default ECC	DEFAULT_ECC	2	R	[30:29]	0h	
Write speed factor	R2W_FACTOR	3	R	[28:26]	2h	
Max. write data block length	WRITE_BL_LEN	4	R	[25:22]	9h	
Partial blocks for write allowed	WRITE_BL_PARTIAL	1	R	[21:21]	0h	
Reserved	-	4	R	[20:17]	0h	
Content protection application	CONTENT_PROT_APP	1	R	[16:16]	0h	
File format group	FILE_FORMAT_GRP	1	R/W	[15:15]	0h	
Copy flag (OTP)	COPY	4GB (Native) 2GB(pSLC)	1	R/W	[14:14]	0h
		8GB (Native) 4GB(pSLC)				1h
Permanent write protection	PERM_WRITE_PROTECT	1	R/W	[13:13]	0h	
Temporary write protection	TMP_WRITE_PROTECT	1	R/W	[12:12]	0h	
File format	FILE_FORMAT	2	R/W	[11:10]	0h	
ECC code	ECC	2	R/W	[9:8]	0h	
CRC	CRC	7	R/W	[7:1]	-	
Reserved(Not used, always'1')	-	1	-	[0:0]	-	

- 1 R = Read-only  
 R/W = One-time programmable and readable

## ECSD Register Field Parameters

Name	Field		Size (Bytes)	Cell Type <sup>(1)</sup>	ECSD Bytes	ECSD Values
Reserved	--		6	--	[511:506]	--
Extended Security Commands Error	EXT_SECURITY_ERR		1	R	[505]	0x00
Supported command sets	S_CMD_SET		1	R	[504]	0x01
HPI features	HPI_FEATURES		1	R	[503]	0x01
Background operations support	BKOPS_SUPPORT		1	R	[502]	0x01
Max packed read commands	MAX_PACKED_READS	4GB(Native) 2GB(pSLC)	1	R	[501]	0x3F
		8GB(Native) 4GB(pSLC)				0x20
Max packed write commands	MAX_PACKED_WRITES	4GB(Native) 2GB(pSLC)	1	R	[500]	0x3F
		8GB(Native) 4GB(pSLC)				0x20
Data tag support	DATA_TAG_SUPPORT		1	R	[499]	0x01
Tag unit size	TAG_UNIT_SIZE		1	R	[498]	0x00
Tag resources size	TAG_RES_SIZE		1	R	[497]	0x00
Context management capabilities	CONTEXT_CAPABILITIES		1	R	[496]	0x78
Large unit size	LARGE_UNIT_SIZE_M1		1	R	[495]	0x01
Extended partitions attribute support	EXT_SUPPORT		1	R	[494]	0x03
Supported Modes	SUPPORTED_MODES		1	R	[493]	0x01
FFU features	FFU_FEATURES		1	R	[492]	0x00
Operations code timeout	OPERATION_CODE_TIMEOUT		1	R	[491]	0x17
FFU Argument	FFU_ARG		4	R	[490:487]	0xFFFAFFF0
Reserved	--		181	--	[486:309]	--
CMD Queuing Support	CMDQ_SUPPORT		1	R	[308]	0x01
CMD Queuing Depth	CMDQ_DEPTH		1	R	[307]	0x1F
Reserved	--		1	--	[306]	--
Number of FW sectors correctly programmed	NUMBER_OF_FW_SECTORS_CORRECTLY_PROGRAMMED		4	R	[305:302]	0x00
Vendor proprietary health report	VENDOR_PROPRIETARY_HEALTH_REPORT		32	R	[301:270]	0x00
Device life time estimation type B	DEVICE_LIFE_TIME_EST_TYP_B		1	R	[269]	Variable

Name	Field		Size (Bytes)	Cell Type <sup>(1)</sup>	ECSD Bytes	ECSD Values
Device life time estimation type A	DEVICE_LIFE_TIME_EST_TYP_A		1	R	[268]	Variable
Pre EOL information	PRE_EOL_INFO		1	R	[267]	Variable
Optimal read size	OPTIMAL_READ_SIZE		1	R	[266]	0x40
Optimal write size	OPTIMAL_WRITE_SIZE		1	R	[265]	0x40
Optimal trim unit size	OPTIMAL_TRIM_UNIT_SIZE		1	R	[264]	0x07
Device Version	Device version	4GB(Native) 2GB(pSLC)	2	R	[263:262]	0x3405
		8GB(Native) 4GB(pSLC)				0x3805
Firmware version	FIRMWARE_VERSION		8	R	[261:254]	-- <sup>(1)</sup>
Power class for 200MHz, DDR at VCC=3.6V	PWR_CL_DDR_200_360		1	R	[253]	0x00
Cache size	CACHE_SIZE		4	R	[252:249]	0x400
Generic CMD6 timeout	GENERIC_CMD6_TIME		1	R	[248]	0x05
Power off notification (long) timeout	POWER_OFF_LONG_TIME		1	R	[247]	0x64
Background operations status	BKOPS_STATUS		1	R	[246]	0x00
Number of correctly programmed sectors	CORRECTLY_PRG_SECTORS_NUM		4	R	[245:242]	0x00
First initialization time after partitioning	INI_TIMEOUT_AP		1	R	[241]	0x0A
Reserved	--		1	--	[240]	--
Power class for 52 MHz, DDR at 3.6V	PWR_CL_DDR_52_360		1	R	[239]	0x00
Power class for 52 MHz, DDR at 1.95V	PWR_CL_DDR_52_195		1	R	[238]	0x00
Power class for 200 MHz at 1.95V, VCC = 3.6V	PWR_CL_200_195		1	R	[237]	0x00
Power class for 200 MHz at 1.3V, VCC = 3.6V	PWR_CL_200_130		1	R	[236]	0x00
Minimum write performance for 8-bit at 52 MHz in DDR mode	MIN_PERF_DDR_W_8_52		1	R	[235]	0x00
Minimum read performance for 8-bit at 52 MHz in DDR mode	MIN_PERF_DDR_R_8_52		1	R	[234]	0x00
Reserved	--		1	--	[233]	--
TRIM multiplier	TRIM_MULT		1	R	[232]	0x02
Secure feature support	SEC_FEATURE_SUPPORT		1	R	[231]	0x55

Name	Field		Size (Bytes)	Cell Type <sup>(1)</sup>	ECSD Bytes	ECSD Values
SECURE ERASE multiplier	SEC_ERASE_MULT	4GB(Native) 2GB(pSLC)	1	R	[230]	0xFF
		8GB(Native) 4GB(pSLC)				0x19
SECURE TRIM multiplier	SEC_TRIM_MULT	4GB(Native) 2GB(pSLC)	1	R	[229]	0xFF
		8GB(Native) 4GB(pSLC)				0x0A
Boot information	BOOT_INFO		1	R	[228]	0x07
Reserved	--		1	--	[227]	--
Boot partition size	BOOT_SIZE_MULT		1	R	[226]	0x20
Access size	ACC_SIZE		1	R	[225]	0x06
High-capacity erase unit size	HC_ERASE_GRP_SIZE		1	R	[224]	0x01
High-capacity erase timeout	ERASE_TIMEOUT_MULT		1	R	[223]	0x02
Reliable write-sector count	REL_WR_SEC_C		1	R	[222]	0x01
High-capacity write protect group size	HC_WP_GRP_SIZE		1	R	[221]	0x10
Sleep current (V <sub>CC</sub> )	S_C_VCC		1	R	[220]	0x07
Sleep current (V <sub>CCQ</sub> )	S_C_VCCQ		1	R	[219]	0x07
Production state awareness timeout	PRODUCTION_STATE_AWARENESS_TIMEOUT		1	R	[218]	0x17
Sleep/awake timeout	S_A_TIMEOUT	4GB(Native) 2GB(pSLC)	1	R	[217]	0x13
		8GB(Native) 4GB(pSLC)				0x12
Sleep Notification Timeout	SLEEP_NOTIFICATION_TIME		1	R	[216]	0x0C
Sector count	SEC-COUNT	4GB(Native)	4	R	[215:212]	0x00748000
		2GB(pSLC)				0x003A4000
		8GB(Native)				0x00E90000
		4GB(pSLC)				0x00748000
Reserved	--		1	--	[211]	--
Minimum write performance for 8-bit at 52 MHz	MIN_PERF_W_8_52		1	R	[210]	0x00

Name	Field		Size (Bytes)	Cell Type <sup>(1)</sup>	ECSD Bytes	ECSD Values
Minimum read performance for 8-bit at 52 MHz	MIN_PERF_R_8_52		1	R	[209]	0x00
Minimum write performance for 8-bit at 26 MHz and 4-bit at 52 MHz	MIN_PERF_W_8_26_4_52		1	R	[208]	0x00
Minimum read performance for 8-bit at 26 MHz and 4-bit at 52 MHz	MIN_PERF_R_8_26_4_52		1	R	[207]	0x00
Minimum write performance for 4-bit at 26 MHz	MIN_PERF_W_4_26		1	R	[206]	0x00
Minimum read performance for 4-bit at 26 MHz	MIN_PERF_R_4_26		1	R	[205]	0x00
Reserved	--		1	--	[204]	--
Power class for 26 MHz at 3.6V 1 R	PWR_CL_26_360		1	R	[203]	0x00
Power class for 52 MHz at 3.6V 1 R	PWR_CL_52_360		1	R	[202]	0x00
Power class for 26 MHz at 1.95V 1 R	PWR_CL_26_195		1	R	[201]	0x00
Power class for 52 MHz at 1.95V 1 R	PWR_CL_52_195		1	R	[200]	0x00
Partition switching timing	PARTITION_S WITCH_TIME	4GB(Native) 2GB(pSLC)	1	R	[199]	0x06
		8GB(Native) 4GB(pSLC)				0x04
Out-of-interrupt busy timing	OUT_OF_INTE RRUPT_TIME	4GB(Native) 2GB(pSLC)	1	R	[198]	0x05
		8GB(Native) 4GB(pSLC)				0x0A
I/O driver strength	DRIVER_STRENGTH		1	R	[197]	0x1F
Card type	CARD_TYPE		1	R	[196]	0x57
Reserved	--		1	--	[195]	--
CSD structure version	CSD_STRUCTURE		1	R	[194]	0x02
Reserved	--		1	--	[193]	--
Extended CSD revision	EXT_CSD_REV		1	--	[192]	0x08
Command set	CMD_SET		1	R/W/E_P	[191]	0x00
Reserved	--		1	--	[190]	--
Command set revision	CMD_SET_REV		1	R	[189]	0x00
Reserved	--		1	--	[188]	--
Power class	POWER_CLASS		1	R/W/E_P	[187]	0x00
Reserved	--		1	--	[186]	--

Name	Field		Size (Bytes)	Cell Type <sup>(1)</sup>	ECSD Bytes	ECSD Values
High-speed interface timing	HS_TIMING		1	R/W/E_P	[185]	0x00
Reserved	--		1	--	[184]	--
Bus width mode	BUS_WIDTH		1	W/E_P	[183]	0x00
Reserved	--		1	--	[182]	--
Erased memory content	ERASED_MEM_CONT		1	R	[181]	0x00
Reserved	--		1	--	[180]	--
Partition configuration	PARTITION_CONFIG		1	R/W/E, R/W/E_P	[179]	0x00
Boot config protection	BOOT_CONFIG_PROT		1	R/W, R/W/C_P	[178]	0x00
Boot bus Conditions	BOOT_BUS_CONDITIONS		1	R/W/E	[177]	0x00
Reserved	--		1	--	[176]	--
High-density erase group definition	ERASE_GROUP_DEF		1	R/W/E_P	[175]	0x00
Boot write protection status registers	BOOT_WP_STATUS		1	R	[174]	0x00
Boot area write protection register	BOOT_WP		1	R/W, R/W/C_P	[173]	0x00
Reserved	--		1	-	[172]	--
User write protection register	USER_WP		1	R/W, R/W/C_P, R/W/E_P	[171]	0x00
Reserved	--		1	--	[170]	--
Firmware configuration	FW_CONFIG		1	R/W	[169]	0x00
RPMB size	RPMB_SIZE_MULT		1	R	[168]	0x20
Write reliability setting register	WR_REL_SET		1	R/W	[167]	0x1F
Write reliability parameter register	WR_REL_PARAM		1	R	[166]	0x15
Start sanitize operation	SANITIZE_START		1	W/E_P	[165]	0x00
Manually start background operations	BKOPS_START		1	W/E_P	[164]	0x00
Enable background operations handshake	BKOPS_EN	4GB(Native) 2GB(pSLC)	1	R/W	[163]	0x00
		8GB(Native) 4GB(pSLC)				0x02
Hardware reset function	RST_n_FUNCTION		1	R/W	[162]	0x00
HPI management	HPI_MGMT		1	R/W/E/P	[161]	0x00

Name	Field		Size (Bytes)	Cell Type <sup>(1)</sup>	ECSD Bytes	ECSD Values
Partitioning support	PARTITIONING_SUPPORT		1	R/W/E, R/W/E_P	[160]	0x07
Maximum enhanced area size	MAX_ENH_SIZE_MULT	4GB(Native) 2GB(pSLC)	3	R	[159:157]	0x0000E9
		8GB(Native) 4GB(pSLC)				0x0001D2
Partitions attribute	PARTITIONS_ATTRIBUTE	4GB(Native) 8GB(Native)	1	R/W	[156]	0x00
		2GB(pSLC) 4GB(pSLC)				0x01
Partitioning setting	PARTITIONING_SETTING_COMPLETED	4GB(Native) 8GB(Native)	1	R/W	[155]	0x00
		2GB(pSLC) 4GB(pSLC)				0x01
General-purpose partition size	GP_SIZE_MULT		12	R/W	[154:143]	0x00
Enhanced user data area size	ENH_SIZE_MULT	4GB(Native) 8GB(Native)	3	R/W	[142:140]	0x00
		2GB(pSLC)				0xE9
		4GB(pSLC)				0x1D2
Enhanced user data start address	ENH_START_ADDR		4	R/W	[139:136]	0x00
Reserved	-		1	-	[135]	--
Bad block management mode	SEC_BAD_BLK_MGMNT		1	R/W	[134]	0x00
Production state awareness	PRODUCTION_STATE_AWARENESS		1	R/W/E	[133]	0x00
Package case temperature is controlled	TCASE_SUPPORT		1	W/E_P	[132]	0x00
Periodic wake-up	PERIODIC_WAKEUP		1	R/W/E	[131]	0x00
Program CID/CSD in DDR mode support	PROGRAM_CID_CSD_DDR_SUPPORT	4GB(Native) 2GB(pSLC)	1	R	[130]	0x00
		8GB(Native) 4GB(pSLC)				0x01
Reserved	-		2	-	[129:128]	--
Vendor specific fields	VENDOR_SPECIFIC_NFIELD		64	<vs>	[127:64]	0x00
Native sector size	NATIVE_SECTOR_SIZE		1	R	[63]	0x01
Sector size emulation	USE_NATIVE_SECTOR		1	R/W	[62]	0x00

Name	Field		Size (Bytes)	Cell Type <sup>(1)</sup>	ECSD Bytes	ECSD Values
Sector size	DATA_SECTOR_SIZE		1	R	[61]	0x00
1st initialization after disabling sector size emulation	INI_TIMEOUT_EMU		1	R	[60]	0x0A
Class 6 command control	CLASS_6_CTRL		1	R/W/E_P	[59]	0x00
Number of addressed groups to be released	DYNCAP_NEEDED		1	R	[58]	0x00
Exception events control	EXCEPTION_EVENTS_CTRL		2	R/W/E_P	[57:56]	0x00
Exception events status	EXCEPTION_EVENTS_STATUS		2	R	[55:54]	0x00
Extended partitions attribute	EXT_PARTITIONS_ATTRIBUTE		2	R/W	[53:52]	0x00
Context configuration	CONTEXT_CONF		15	R/W/E_P	[51:37]	0x00
Packed command status	PACKED_COMMAND_STATUS		1	R	[36]	0x00
Packed command failure index	PACKED_FAILURE_INDEX		1	R	[35]	0x00
Power off notification	POWER_OFF_NOTIFICATION		1	R/W/E_P	[34]	0x00
Control to turn the cache on/off	CACHE_CTRL		1	R/W/E_P	[33]	0x00
Flushing of the cache	FLUSH_CACHE		1	W/E_P	[32]	0x00
Control to turn the Barrier ON/OFF	BARRIER_CTRL		1	R/W	[31]	0x00
Mode config	MODE_CONFIG		1	R/W/E_P	[30]	0x00
Mode operation codes	MODE_OPERATION_CODES		1	W/E_P	[29]	0x00
Reserved	-		2	-	[28:27]	--
FFU status	FFU_STATUS		1	R	[26]	0x00
Pre loading data size	PRE_LOADING_DATA_SIZE		4	R/W/E_P	[25:22]	0x00
Max pre loading data size	MAX_PRE_LOADING_DATA_SIZE	4GB(Native) 2GB(pSLC)	4	R	[21:18]	0x00748000
		8GB(Native) 4GB(pSLC)				0x00E90000
Product state awareness enablement	PRODUCT_STATE_AWARENESS_ENABLEMENT		1	R/W/E & R	[17]	0x01
Secure removal type	SECURE_REMOVAL_TYPE		1	R/W & R	[16]	0x3B
Reserved	-		16	-	[15:0]	--

Note:

(1) FIRMWARE\_VERSION depends on capacity.



## Part Numbers

### Part Numbering Information

The following table lists the available devices for this family.

#### Part Numbering Information

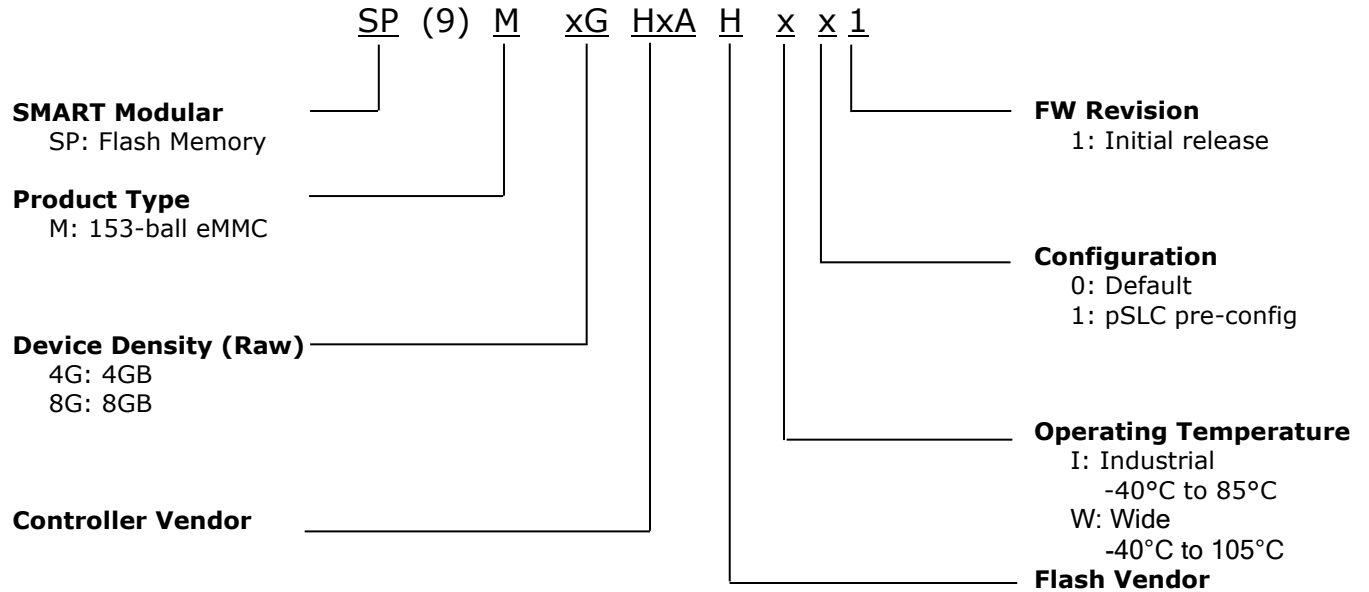
##### Industrial Temperature

Part Number	Capacity
<i>Native MLC</i>	
SP9M4GH1AHI01	4GB
SPM8GH2AHI01	8GB
<i>Pre-Configured to pSLC</i>	
SP9M4GH1AHI11	2GB
SPM8GH2AHI11	4GB

##### Wide Temperature

Part Number	Capacity
<i>Pre-Configured to pSLC</i>	
SPM8GH2AHW11	4GB

## Part Number Decoder



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## Declaration of Conformity

Responsible Party Name: SMART Modular Technologies, Inc.  
Address: 39870 Eureka Drive  
Newark, CA 94560-4809, USA  
Phone: +1-510-623-1231

Hereby declares that the products:

### **SPxMxGHxAHxx1**

to which this declaration relates are in conformity with the following Directives and other normative documents:

#### **RoHS Directive 2011/65/EU and its amendments**

Restriction of the use of hazardous substances in electrical and electronic equipment

- **EN 50581:2012**  
Technical documentation for the assessment of electrical and electronic products with respect to the restriction of hazardous substances

Name: Jeffrey Milano  
Title: Director, Worldwide Quality  
Date: March 11, 2025 3:15 PM

#### **Representative in the European Union (for regulatory topics only):**

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